## Notice of References Cited Application/Control No. 10/536,601 Examiner Sze-Hon Kong Applicant(s)/Patent Under Reexamination LEE ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,687,084 A	11-1997	Wertz, James R.	701/226
*	В	US-5,806,802 A	09-1998	Scott, David D.	244/172.4
*	C	US-6,056,237 A	05-2000	Woodland, Richard L. K.	244/3.15
*	D	US-6,275,677 B1	08-2001	Tandler, John J.	455/12.1
*	Е	US-6,317,660 B1	11-2001	Barker et al.	701/13
*	F	US-6,417,798 B1	07-2002	Joerck, Hartmut	342/355
*	G	US-6,735,501 B1	05-2004	Rulison et al.	701/13
	Ι	US-			
	-	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	>					
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	х					

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